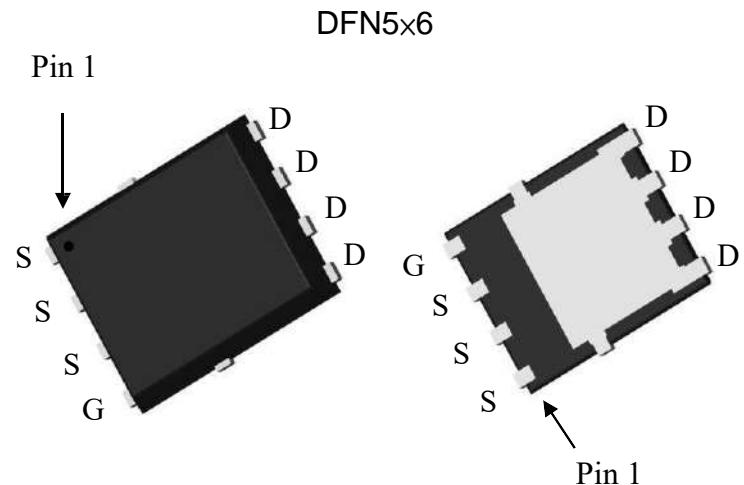


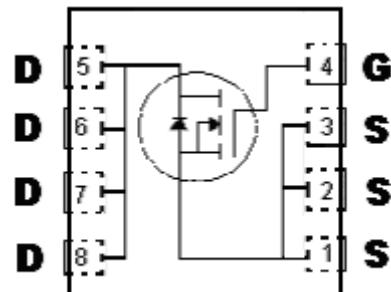
N-Channel Logic Level Enhancement Mode Power MOSFET

Features:

- Single Drive Requirement
- Low On-resistance
- Fast Switching Characteristic
- Pb-free lead plating and Halogen-free package



BV_{DSS}	30V
I_D@V_{GS}=10V, T_C=25°C	60A
I_D@V_{GS}=10V, T_A=25°C	19.2A
R_{DS(ON)}@V_{GS}=10V, I_D=30A	2.5 mΩ(typ)
R_{DS(ON)}@V_{GS}=4.5V, I_D=24A	3.5 mΩ(typ)



G : Gate D : Drain S : Source

Ordering Information

Device	Package	Shipping
KWB3D0N03BH8	DFN 5x6 (Pb-free lead plating and halogen-free package)	3000 pcs / tape & reel

Absolute Maximum Ratings ($T_a=25^\circ C$)

Parameter	Symbol	Limits	Unit
Drain-Source Voltage	V_{DS}	30	V
Gate-Source Voltage	V_{GS}	± 20	
Continuous Drain Current @ $T_c=25^\circ C$, $V_{GS}=10V$ (Silicon limit)	I_D	86	A
Continuous Drain Current @ $T_c=100^\circ C$, $V_{GS}=10V$ (Silicon limit)		54	
Continuous Drain Current @ $T_c=25^\circ C$, $V_{GS}=10V$ (Package limit)		60	
Continuous Drain Current @ $T_A=25^\circ C$, $V_{GS}=10V$	I_{DSM}	19.2 *3	A
Continuous Drain Current @ $T_A=70^\circ C$, $V_{GS}=10V$		15.4 *3	
Pulsed Drain Current	I_{DM}	200 *1	
Avalanche Current	I_{AS}	46	
Avalanche Energy @ $L=0.1mH$, $I_D=46A$, $R_G=25\Omega$	E_{AS}	106	mJ
Total Power Dissipation	$T_c=25^\circ C$	P_D	50
	$T_c=100^\circ C$		20
	$T_A=25^\circ C$	P_{DSM}	2.5 *3
	$T_A=70^\circ C$		1.6 *3
Operating Junction and Storage Temperature Range	T_j , T_{stg}	-55~+150	$^\circ C$

100% UIS testing in condition of $V_D=15V$, $L=0.1mH$, $V_G=10V$, $I_L=30A$, Rated $V_{DS}=30V$ N-CH

Thermal Data

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-case, max	$R_{th,j-c}$	2.5	
Thermal Resistance, Junction-to-ambient, max	$R_{th,j-a}$	50 *3	$^\circ C/W$

Note : 1. Pulse width limited by maximum junction temperature
 2. Duty cycle $\leq 1\%$
 3. Surface mounted on 1 in² copper pad of FR-4 board, $t \leq 10s$; $125^\circ C/W$ when mounted on minimum copper pad.

Characteristics ($T_c=25^\circ C$, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV_{DSS}	30	-	-	V	$V_{GS}=0V$, $I_D=250\mu A$
$V_{GS(th)}$	1.0	-	2.5		$V_{DS} = V_{GS}$, $I_D=250\mu A$
G_{FS} *1	-	41	-	S	$V_{DS}=5V$, $I_D=20A$
I_{GSS}	-	-	± 100	nA	$V_{GS}=\pm 20V$, $V_{DS}=0V$
I_{DS}	-	-	1	μA	$V_{DS}=24V$, $V_{GS}=0V$
	-	-	25		$V_{DS}=20V$, $V_{GS}=0V$, $T_j=125^\circ C$
$R_{DS(ON)}$ *1	-	2.5	3.5	$m\Omega$	$V_{GS}=10V$, $I_D=30A$
	-	3.5	5.0		$V_{GS}=4.5V$, $I_D=24A$
Dynamic					
C_{iss}	-	2355	-	pF	$V_{GS}=0V$, $V_{DS}=15V$, $f=1MHz$
C_{oss}	-	419	-		
C_{rss}	-	232	-		

Characteristics (Tc=25°C, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Qg ($V_{GS}=10V$) *1, 2	-	47.2	-	nC	$V_{DS}=15V, V_{GS}=10V, I_D=30A$
Qg ($V_{GS}=4.5V$) *1, 2	-	24	-		
Qgs *1, 2	-	8.3	-		
Qgd *1, 2	-	10.2	-		
$t_{d(ON)}$ *1, 2	-	16.4	-		
tr *1, 2	-	19.2	-	ns	$V_{DS}=15V, I_D=24A, V_{GS}=10V, R_{GS}=2.7\Omega$
$t_{d(OFF)}$ *1, 2	-	53.4	-		
t_f *1, 2	-	12.2	-		
Rg	-	0.76	-	Ω	f=1MHz

Source-Drain Diode

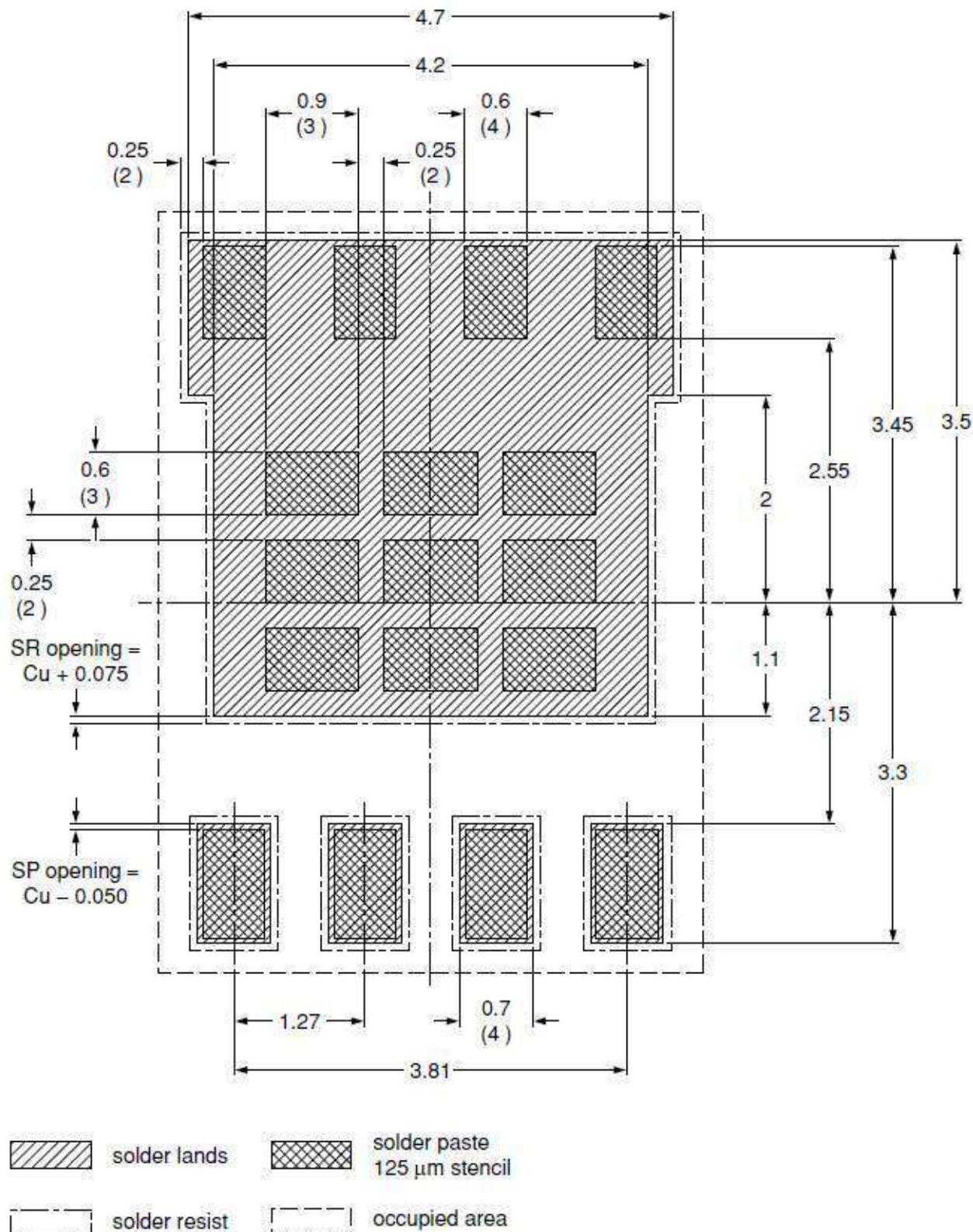
I _S *1	-	-	60	A	
I _{SM} *3	-	-	200		
V _{SD} *1	-	0.81	1.2	V	I _s =20A, V _{GS} =0V
trr	-	16.1	-	ns	I _F =24A, dI _F /dt=100A/μs
Qrr	-	8.4	-		

Note : *1.Pulse Test : Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$

*2.Independent of operating temperature

*3.Pulse width limited by maximum junction temperature.

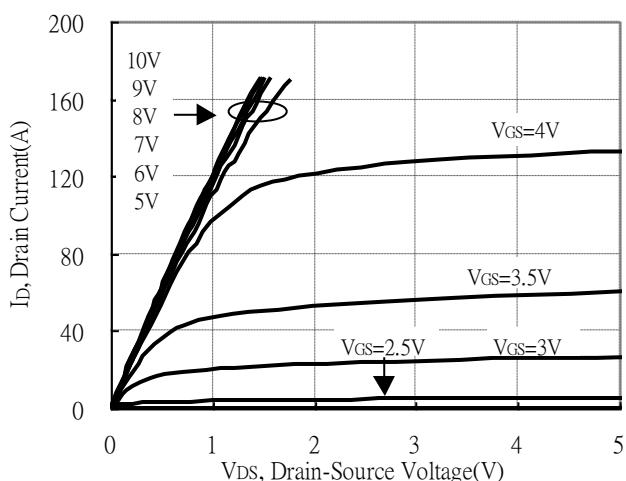
Recommended Soldering Footprint & Stencil Design



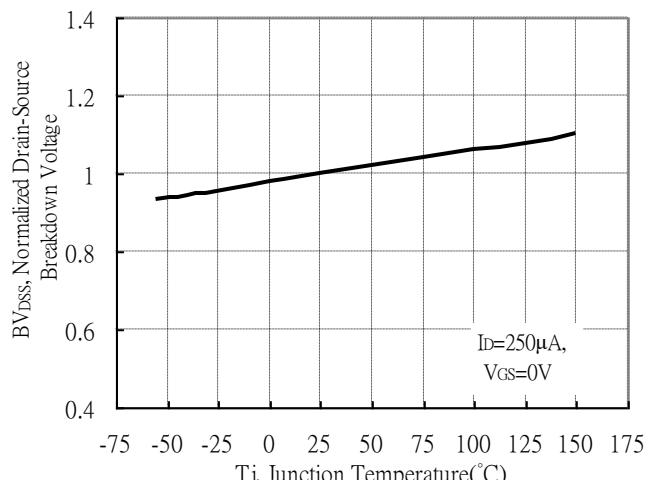
unit : mm

Typical Characteristics

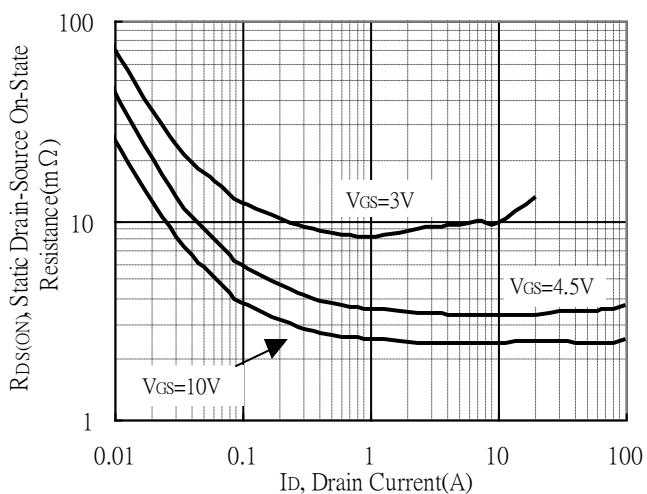
Typical Output Characteristics



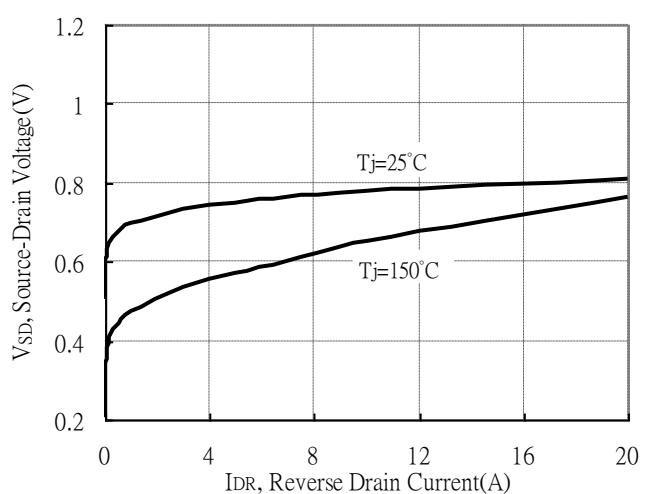
Breakdown Voltage vs Ambient Temperature



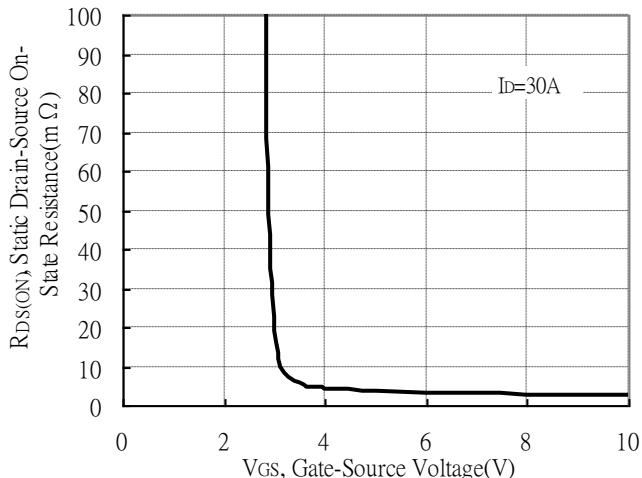
Static Drain-Source On-State resistance vs Drain Current



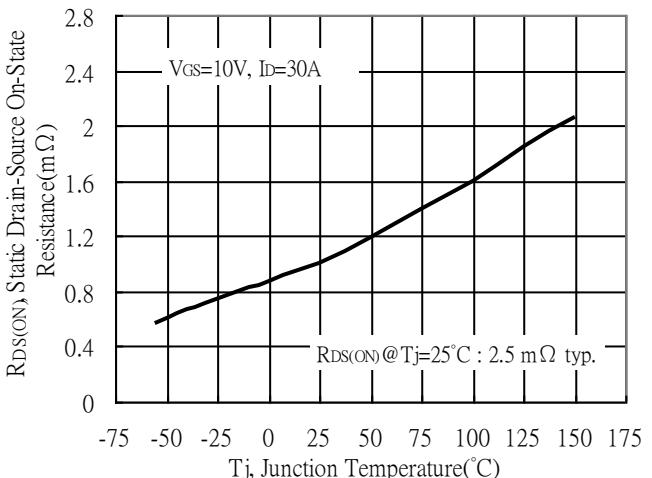
Reverse Drain Current vs Source-Drain Voltage



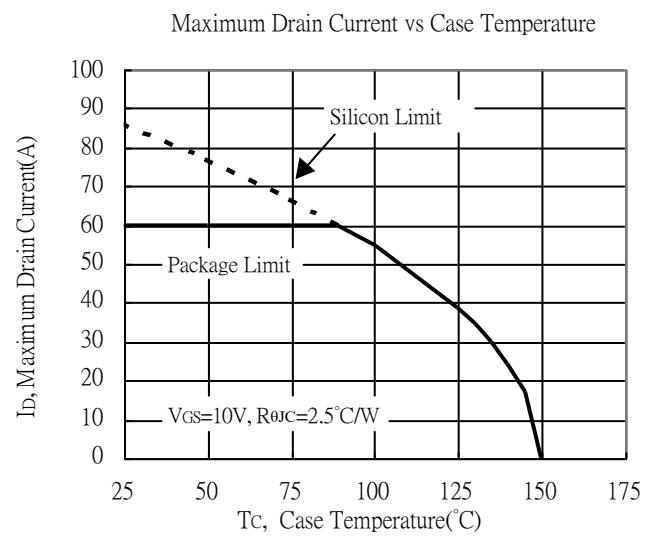
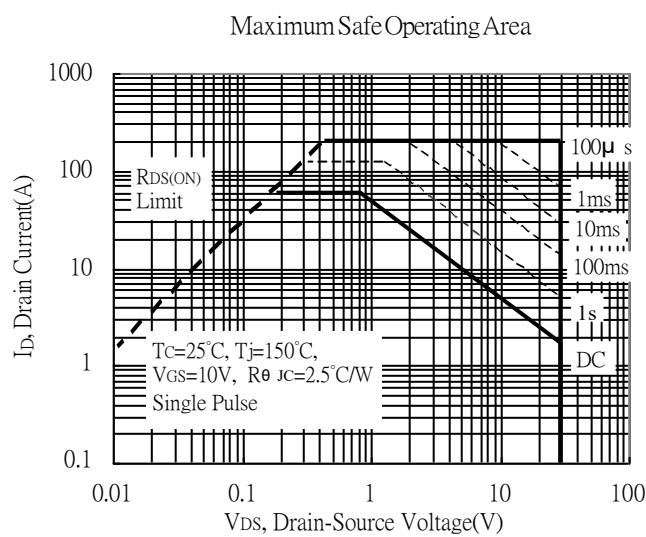
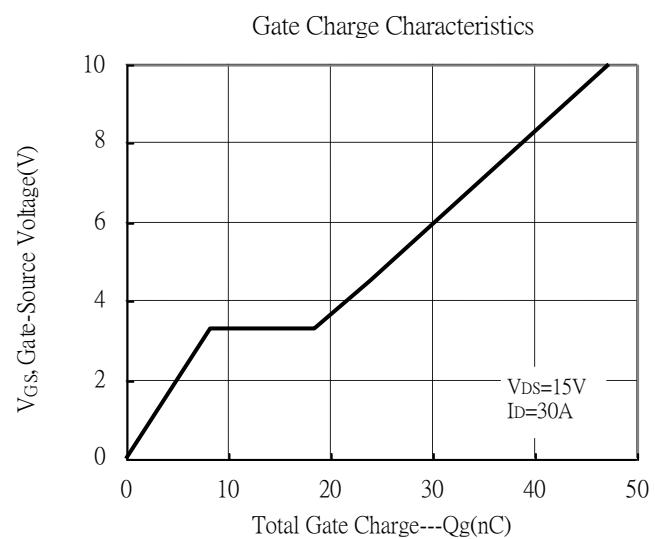
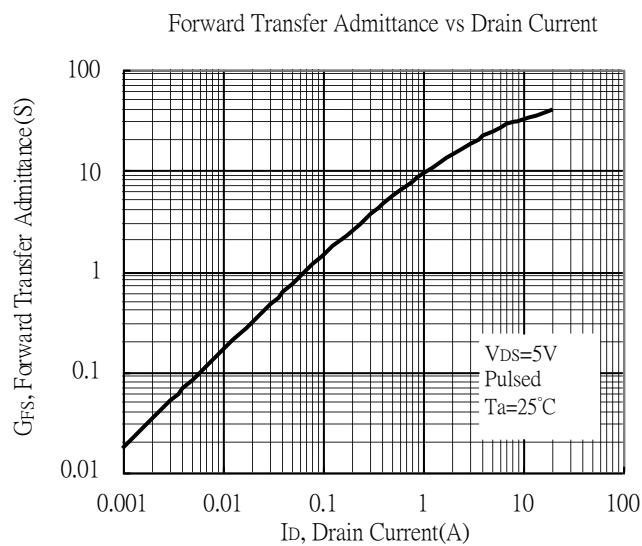
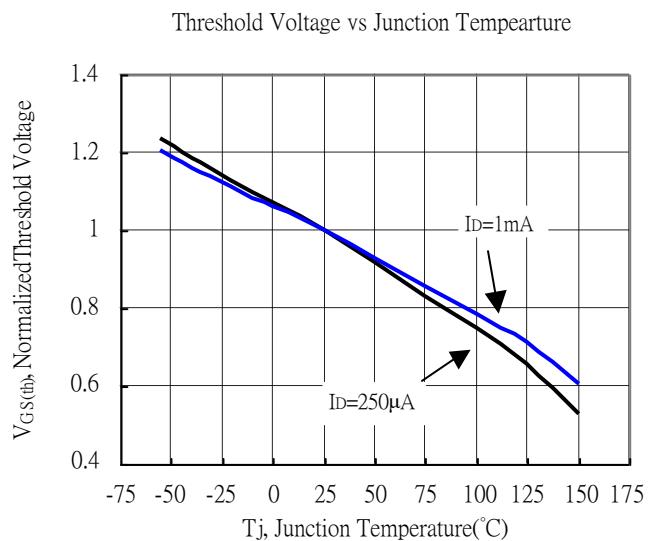
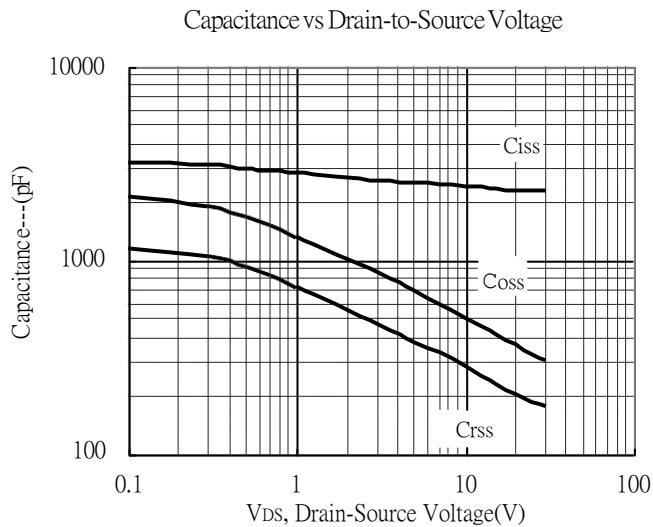
Static Drain-Source On-State Resistance vs Gate-Source Voltage



Drain-Source On-State Resistance vs Junction Temperature

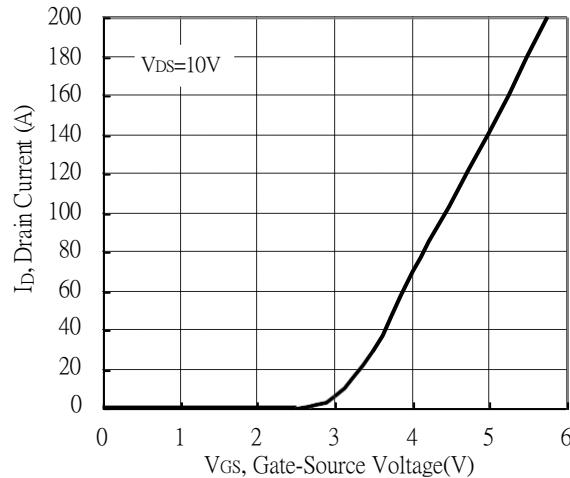


Typical Characteristics(Cont.)

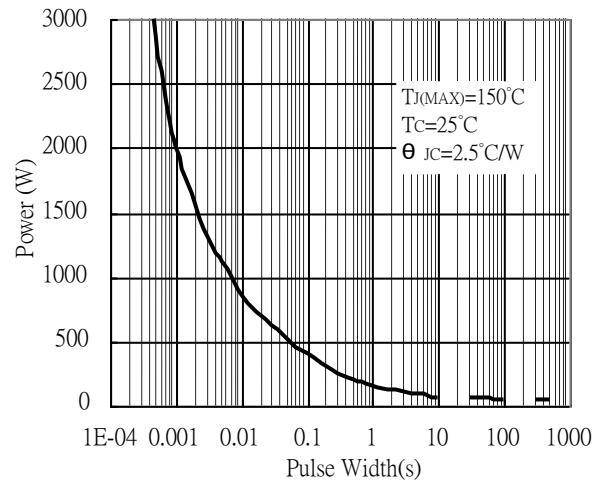


Typical Characteristics(Cont.)

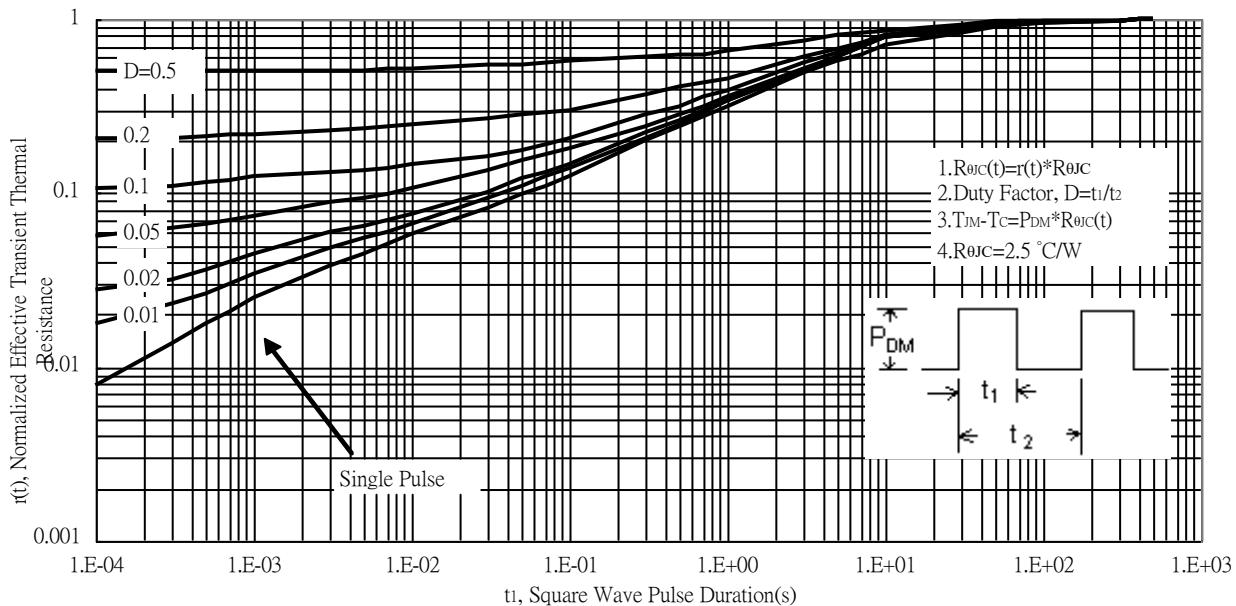
Typical Transfer Characteristics



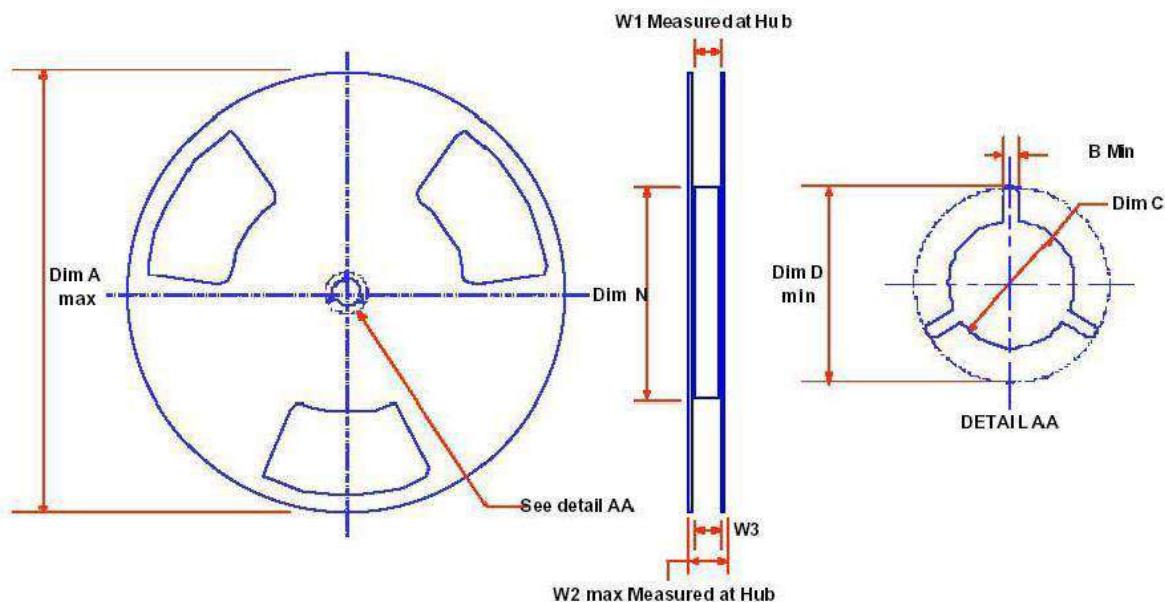
Single Pulse Maximum Power Dissipation



Transient Thermal Response Curves



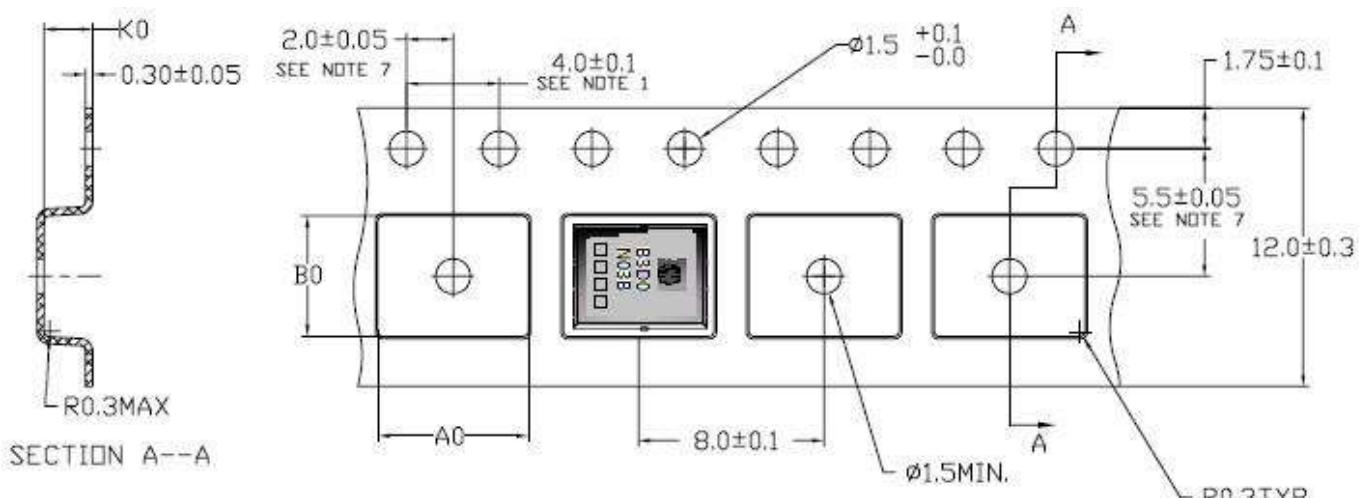
Reel Dimension



Dimensions are in inches and millimeters

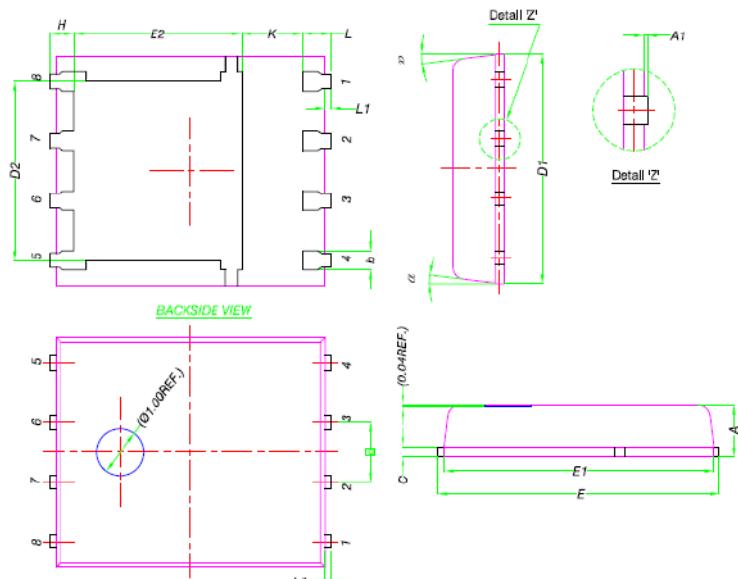
Tape Size	Reel Option	Dim A	Dim B	Dim C	Dim D	Dim N	Dim W1	Dim W2	Dim W3 (LSL-USL)
12mm.	13" Dia (STD/L99Z)	13.00 330 \pm 1	0.069 1.5 Min.	0.512 13.0 Min.	0.795 20.2(ref.)	7.00 178 \pm 2	0.488 +0.078/-0.000 12.4 +2/0	0.724 18.4(ref.)	0.469 - 0.606 11.9 - 15.4

Carrier Tape Dimension

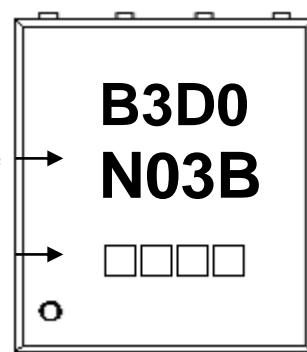


A0=6.5 \pm 0.1
 B0=5.3 \pm 0.1
 K0=1.4 \pm 0.1

DFN5x6 Dimension



Marking:



Date Code :

1st digit : year code, last digit of Christian year
 2nd digit : month code, Jan→A, Feb→B, Mar→C,
 Apr→D, May→E, Jun→F, Jul→G, Aug
 →H, Sep→J, Oct→K, Nov→L, Dec→M
 3rd and 4th digits : serial number of production lot

8-Lead DFN5x6 Plastic Package

Package Code : H8

DIM	Millimeters		Inches		DIM	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.90	1.10	0.035	0.043	E2	3.38	3.78	0.133	0.149
A1	0.00	0.05	0.000	0.002	e	1.27	BSC	0.050	BSC
b	0.33	0.51	0.013	0.020	H	0.41	0.61	0.016	0.024
C	0.20	0.30	0.008	0.012	K	1.10	-	0.043	-
D1	4.80	5.00	0.189	0.197	L	0.51	0.71	0.020	0.028
D2	3.61	3.96	0.142	0.156	L1	0.06	0.20	0.002	0.008
E	5.90	6.10	0.232	0.240	θ	8°	12°	8°	12°
E1	5.70	5.80	0.224	0.228					